

Search Notes

Application/Control No.

10/690,117

Examiner

Cheukfan Lee

Applicant(s)/Patent under
Reexamination

YOSHIDA, MIINORU

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
358	497,494, 474,471	12/2/2005	C.L.
	487,506		
	505,509		
	475,484		
	482,483		
250	208.1		
	234-236		
	216		
	227.11		
399	379,380		
	211,212		
382	312		
	318,319		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: see result	12/2/2005	C.L.
Inventor search		
Note for myself: Indep. claim 1: 3 rd embodiment, p38+, Indep. claim 2: 3 rd embodiment-- modified, p44,p45,L20+-		
Note (cont.): claims 3 and 4: p41, p42, of spec		
Furusawa et al. (6,357,903): scanner light wavelength mainly use wavelength 570 nm, col. 7, lines 20- 30, for claim 4		
Kawai et al. (4,996,606): scanner light wavelengths, col. 3, lines 50-65, for claim 4		